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Application/Control No.	Applicant(s)/Patent under Reexamination	Applicant(s)/Patent under Reexamination	
10/543,136	TANIKAWA, AKIO		
Examiner	Art Unit		
Caridad M. Everhart	2891		

SEARCHED				
Class	Subclass	Date	Examiner	
257	2	9/29/2007	СМЕ	
		,		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	:			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
		DATE	EXMR
EAST(attached)		9/29/2007	СМЕ
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